

APT10M09B2VFR APT10M09LVFR 100V 100A 0.01Ω

B2VFR

Microsemi Product Portfolio

POWER MOS V[®] FREDFET

Power MOS V[®] is a new generation of high voltage N-Channel enhancement mode power MOSFETs. This new technology minimizes the JFET effect, increases packing density and reduces the on-resistance. Power MOS V[®] also achieves faster switching speeds through optimized gate layout.

- T-MAX[™] or TO-264 Package
- Avalanche Energy Rated

- Faster Switching
- FAST RECOVERY BODY DIODE



LVFR

`Q-26

MAXIMUM RATINGS

Lower Leakage

All Ratings: $T_C = 25^{\circ}C$ unless otherwise specified.

Symbol	Parameter	APT10M09B2VFR_LVFR	UNIT		
V _{DSS}	Drain-Source Voltage	100	Volts		
Ι _D	Continuous Drain Current ⁽⁶⁾ @ $T_{C} = 25^{\circ}C$	100	Amps		
I _{DM}	Pulsed Drain Current ^①	400	Ашра		
V _{GS}	Gate-Source Voltage Continuous	±30	Volts		
V_{GSM}	Gate-Source Voltage Transient	±40	VOIIS		
P _D	Total Power Dissipation @ $T_{C} = 25^{\circ}C$	625	Watts		
	Linear Derating Factor	5.00	W/°C		
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C		
Τ _L	Lead Temperature: 0.063" from Case for 10 Sec.	300			
I _{AR}	Avalanche Current ⁽¹⁾ (Repetitive and Non-Repetitive)	100	Amps		
E _{AR}	Repetitive Avalanche Energy ^①	50	mJ		
E _{AS}	Single Pulse Avalanche Energy ④	3000	IIIJ		

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	МАХ	UNIT
BV _{DSS}	Drain-Source Breakdown Voltage ($V_{GS} = 0V, I_{D} = 250\mu A$)	100			Volts
R _{DS(on)}	Drain-Source On-State Resistance ⁽²⁾ ($V_{GS} = 10V$, $I_{D} = 50A$)			0.01	Ohms
I _{DSS}	Zero Gate Voltage Drain Current ($V_{DS} = 100V, V_{GS} = 0V$)			100	μA
	Zero Gate Voltage Drain Current ($V_{DS} = 80V$, $V_{GS} = 0V$, $T_{C} = 125^{\circ}C$)			500	
I _{GSS}	Gate-Source Leakage Current ($V_{GS} = \pm 30V$, $V_{DS} = 0V$)			±100	nA
V _{GS(th)}	Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_{D} = 2.5$ mA)	2		4	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

DYNAMIC CHARACTERISTICS

APT10M09B2VFR_LVFR

Symbol	Characteristic	Test Conditions	MIN	ТҮР	МАХ	UNIT
C _{iss}	Input Capacitance	V _{GS} = 0V		9875		
C _{oss}	Output Capacitance	$V_{DS} = 25V$		3940		pF
C _{rss}	Reverse Transfer Capacitance	f = 1 MHz		1470		
Q _g	Total Gate Charge ^③	V _{GS} = 10V		350		
Q _{gs}	Gate-Source Charge	$V_{DD} = 50V$		60		nC
Q _{gd}	Gate-Drain ("Miller") Charge	I _D = 100A @ 25°C		180		
t _{d(on)}	Turn-on Delay Time	V _{GS} = 15V		18		
t r	Rise Time	$V_{DD} = 50V$		36		ns
t _{d(off)}	Turn-off Delay Time	I _D = 100A @ 25°C		50		115
t _f	Fall Time	R _G = 0.6Ω		9		

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

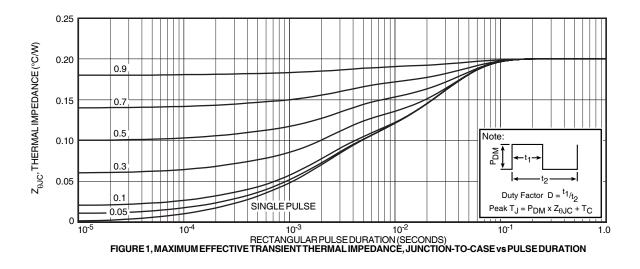
Symbol	Characteristic / Test Conditions		MIN	TYP	MAX	UNIT
ا _S	Continuous Source Current (Body Diode)				100	Amps
I _{SM}	Pulsed Source Current $\textcircled{1}$ (Body Diode)				400	Апрэ
V_{SD}	Diode Forward Voltage ⁽²⁾ ($V_{GS} = 0V$, $I_S = -100A$)				1.3	Volts
dv/ _{dt}	Peak Diode Recovery dv/ _{dt} ⑤				8	V/ns
+	Reverse Recovery Time	T _j = 25°C			190	
t _{rr}	(I _S = -100A, ^{di} / _{dt} = 100A/µs)	T _j = 125°C			370	ns
	Reverse Recovery Charge	T _j = 25°C		0.4		
Q _{rr}	(I _S = -100A, ^{di/} _{dt} = 100A/µs)	T _j = 125°C		1.7		μC
I _{RRM}	Peak Recovery Current	T _j = 25°C		9		A.m.n.a
	(I _S = -100A, ^{di/} _{dt} = 100A/µs)	T _j = 125°C		15		Amps

THERMAL CHARACTERISTICS

Symbo	Characteristic	MIN	ТҮР	MAX	UNIT
R_{\thetaJC}	Junction to Case			0.20	°C/W
R_{\thetaJA}	Junction to Ambient			40	

- Repetitive Rating: Pulse width limited by maximum junction temperature
- (2) Pulse Test: Pulse width < 380 μ s, Duty Cycle < 2%
- ③ See MIL-STD-750 Method 3471

- (4) Starting $T_j = +25^{\circ}C$, L = 0.60mH, $R_G = 25\Omega$, Peak I_L = 100A
- ⑤ ^{dv}/_{dt} numbers reflect the limitations of the test circuit rather than the device itself. I_S ≤ -I_D100A ^{di}/_{dt} ≤ 200A/µs V_R≤100V T_J≤ 150°C
 ⑥ The maximum current is limited by lead temperature.
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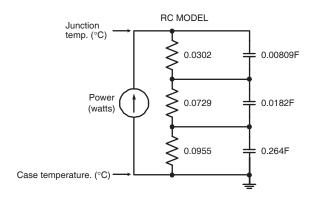
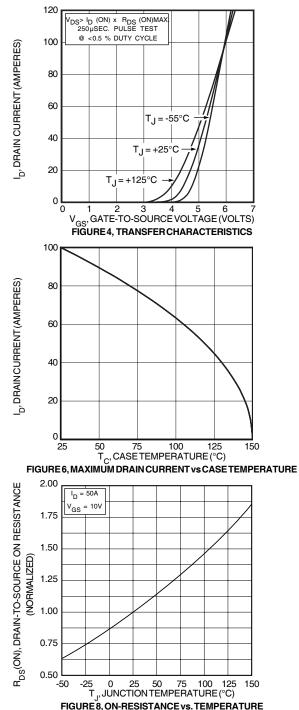
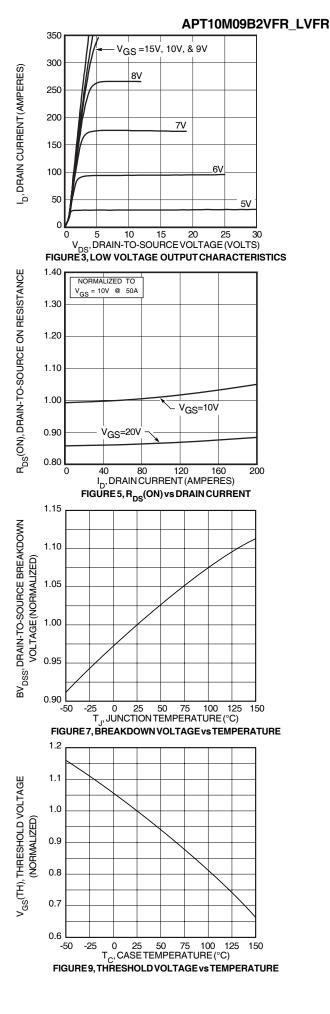
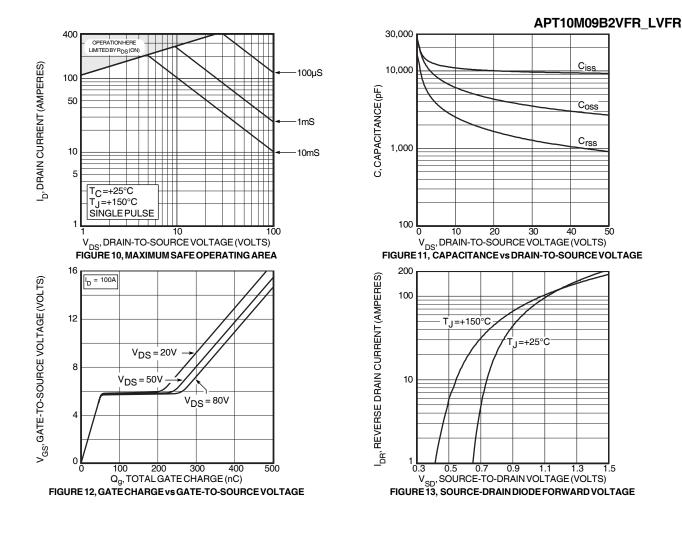
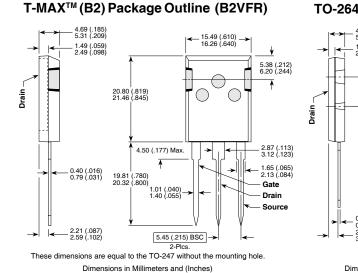


FIGURE 2, TRANSIENT THERMAL IMPEDANCE MODEL

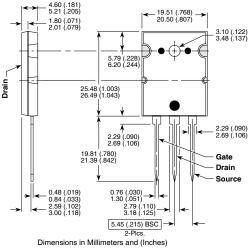












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